

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/552,487	YAMAKAWA ET AL.
Examiner		Art Unit
Patricia T. Nguyen		2817

INTERFERENCE SEARCHED				
Class		Subclass	Date	Examiner
330		289	2/3/2008	PN
		295		
		296		
455/127.1				